

**Notice of References Cited**

Application/Control No.

10/825,560

Applicant(s)/Patent Under  
Reexamination  
AREND ET AL.

Examiner

Alvin H. Tan

Art Unit

2173

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0082857	06-2002	Skordin et al.	705/1
*	B	US-2003/0050911	03-2003	Lucovsky et al.	707/1
*	C	US-2005/0005234	01-2005	Chen, Yen-Fu	715/508
*	D	US-2007/0129953	06-2007	Cunningham et al.	705/001
*	E	US-7,278,113	10-2007	Racine et al.	715/780
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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